



# 600V Super-junction Power MOSFET

## Description

### 600V Super-junction Power MOSFET

Super-junction power MOSFET is a revolutionary technology for high voltage power MOSFETs, designed according to the SJ principle and pioneered. The Multi-EPI SJ MOSFET provide an extremely fast and robust body diode. Also provide an extremely low switching, communication and conduction losses device with highest robustness make especially resonant switching applications more reliable, more efficient, lighter and cooler, designed by Wuxi Unigroup Microelectronics Company.

## Features

- Ultra-fast body diode
- Very low FOM  $R_{DS(on)} \times Q_g$
- Easy to use/drive
- 100% avalanche tested
- RoHS compliant

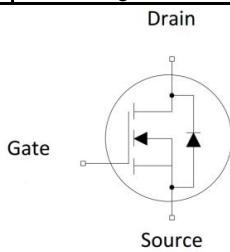
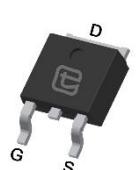
## Applications

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)
- LLC Half-bridge
- Charger

TO-220F



TO-252



## Device Marking and Package Information

Device	Package	Marking
TPA60R600MFD	TO-220F	60R600MFD
TPD60R600MFD	TO-252	60R600MFD

## Key Performance Parameters

Parameter	Value	Unit
$V_{DS} @ T_{j,max}$	650	V
$R_{DS(on),max}$	0.6	$\Omega$
$Q_{g,typ}$	14.2	nC
$I_D$	7	A
$I_{D,pulse}$	21	A
$E_{OSS} @ 400V$	1.95	$\mu J$
Body Diode $dI/dt$	500	A/ $\mu s$
$t_{rr}$	129	ns
$Q_{rr}$	0.71	$\mu C$
$I_{rm}$	11	A

**Absolute Maximum Ratings  $T_C = 25^\circ\text{C}$ , unless otherwise noted**

Parameter	Symbol	Value	Unit
Continuous Drain Current $T_C = 25^\circ\text{C}$	$I_D$	7	A
$T_C = 100^\circ\text{C}$		4.2	
Pulsed Drain Current (note1)	$I_{D,\text{pulse}}$	21	A
Gate-Source Voltage	$V_{GSS}$	$\pm 30$	V
Single Pulse Avalanche Energy (note2)	$E_{AS}$	142	mJ
Repetitive Avalanche Energy (note2)	$E_{AR}$	0.21	mJ
Avalanche Current	$I_{AR}$	1.3	A
MOSFET dv/dt Ruggedness, $V_{DS} = 0 \dots 480\text{V}$	dv/dt	50	V/ns
Power Dissipation For TO-220F	$P_D$	28	W
Power Dissipation For TO-252		63	
Continuous Diode Forward Current	$I_S$	7	A
Diode Pulsed Current (note1)	$I_{S,\text{pulse}}$	21	
Reverse Diode dv/dt (note3)	dv/dt	15	V/ns
Maximum Diode Commutation Speed (note3)	di/dt	500	A/ $\mu\text{s}$
Operating Junction and Storage Temperature Range	$T_J, T_{stg}$	-55~+150	°C

**Thermal Resistance For TO-220F**

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case	$R_{thJC}$	4.5	°C/W
Thermal Resistance, Junction-to-Ambient	$R_{thJA}$	80	

**Thermal Resistance For TO-252**

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case	$R_{thJC}$	2.0	°C/W
Thermal Resistance, Junction-to-Ambient	$R_{thJA}$	62	

**Electrical Characteristics**  $T_J = 25^\circ\text{C}$ , unless otherwise noted

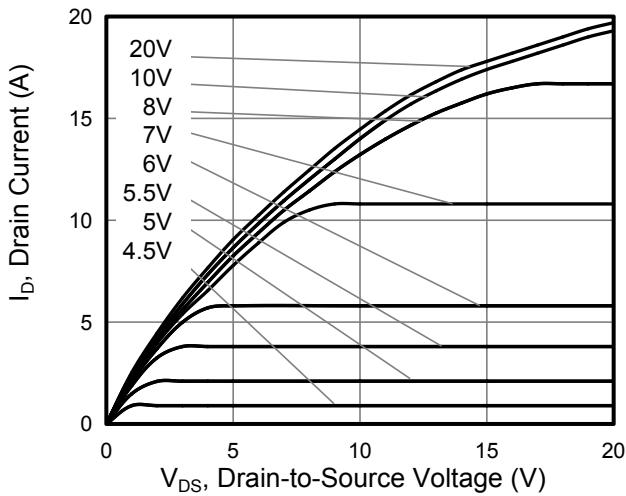
Parameter	Symbol	Test Conditions	Value			Unit
			Min.	Typ.	Max.	
<b>Static Characteristics</b>						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}} = 0\text{V}, I_D = 250\mu\text{A}$	600	--	--	V
Zero Gate Voltage Drain Current	$I_{\text{DSS}}$	$V_{\text{DS}} = 600\text{V}, V_{\text{GS}} = 0\text{V}, T_J = 25^\circ\text{C}$	--	--	1	$\mu\text{A}$
Gate-Source Leakage Current	$I_{\text{GSS}}$	$V_{\text{GS}} = \pm 30\text{V}$	--	--	$\pm 100$	nA
Gate-Source Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250\mu\text{A}$	3.0	--	5.0	V
Drain-Source On-State-Resistance	$R_{\text{DS}(\text{on})}$	$V_{\text{GS}} = 10\text{V}, I_D = 3.5\text{A}$	--	0.53	0.6	$\Omega$
Gate resistance	$R_G$	f = 1.0MHz open drain	--	7	--	$\Omega$
<b>Dynamic Characteristics</b>						
Input Capacitance	$C_{\text{iss}}$	$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 100\text{V}, f = 1.0\text{MHz}$	--	573	--	pF
Output Capacitance	$C_{\text{oss}}$		--	29	--	
Reverse Transfer Capacitance	$C_{\text{rss}}$		--	2.3	--	
Total Gate Charge	$Q_g$	$V_{\text{DD}} = 480\text{V}, I_D = 7\text{A}, V_{\text{GS}} = 10\text{V}$	--	14.2	--	nC
Gate-Source Charge	$Q_{\text{gs}}$		--	4.2	--	
Gate-Drain Charge	$Q_{\text{gd}}$		--	5.8	--	
Turn-on Delay Time	$t_{\text{d}(\text{on})}$	$V_{\text{DD}} = 400\text{V}, I_D = 7\text{A}, R_G = 25\Omega$	--	61	--	ns
Turn-on Rise Time	$t_r$		--	61	--	
Turn-off Delay Time	$t_{\text{d}(\text{off})}$		--	84	--	
Turn-off Fall Time	$t_f$		--	47	--	
<b>Drain-Source Body Diode Characteristics</b>						
Body Diode Voltage	$V_{\text{SD}}$	$T_J = 25^\circ\text{C}, I_{\text{SD}} = 3.5\text{ A}, V_{\text{GS}} = 0\text{V}$	--	1.0	1.5	V
Reverse Recovery Time	$t_{\text{rr}}$	$V_R = 400\text{V}, I_F = 7\text{A}, dI_F/dt = 100\text{A}/\mu\text{s}$	--	129	--	ns
Reverse Recovery Charge	$Q_{\text{rr}}$		--	0.71	--	
Peak Reverse Recovery Current	$I_{\text{rrm}}$		--	11	--	

**Notes**

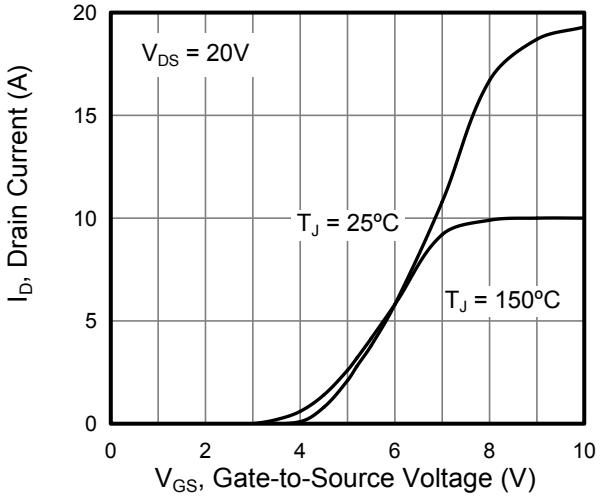
- Repetitive Rating: Pulse width limited by maximum junction temperature
- $I_{\text{AS}} = 2.4\text{A}, V_{\text{DD}} = 50\text{V}, R_G = 25\Omega$ , Starting  $T_J = 25^\circ\text{C}$
- Identical low side and high side switch with identical  $R_G$

**Typical Characteristics**  $T_J = 25^\circ\text{C}$ , unless otherwise noted

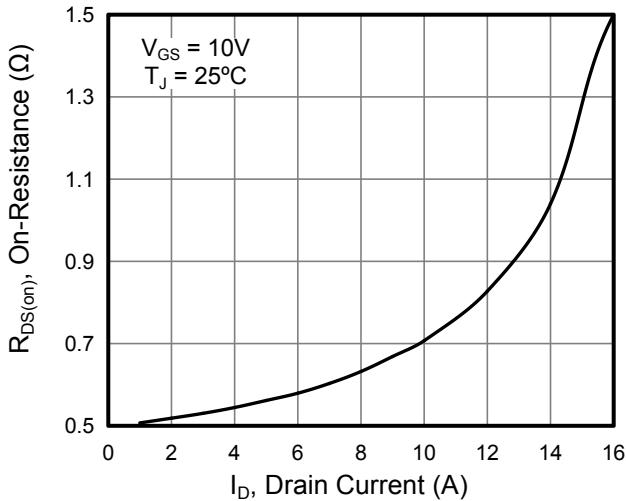
**Figure 1. Output Characteristics**



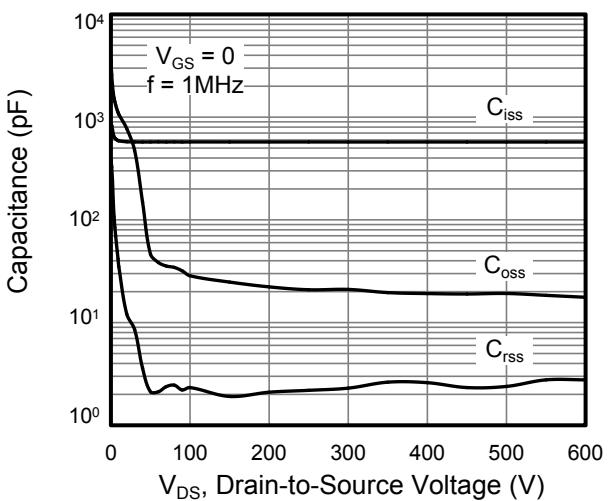
**Figure 2. Transfer Characteristics**



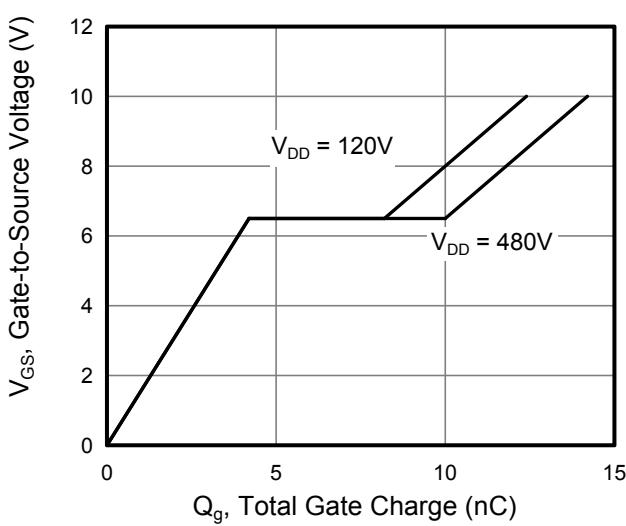
**Figure 3. On-Resistance vs. Drain Current**



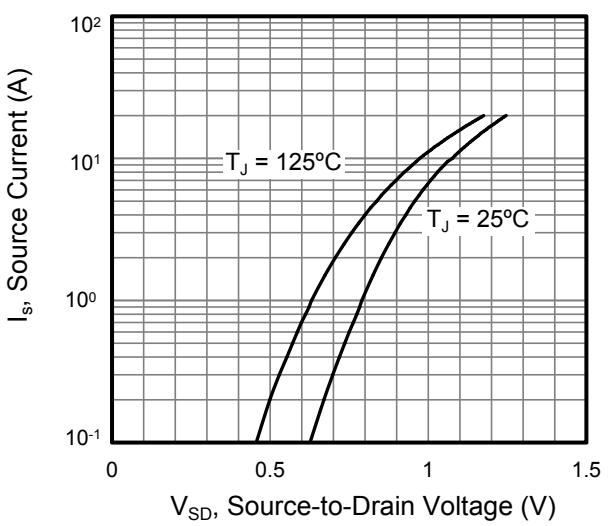
**Figure 4. Capacitance**



**Figure 5. Gate Charge**

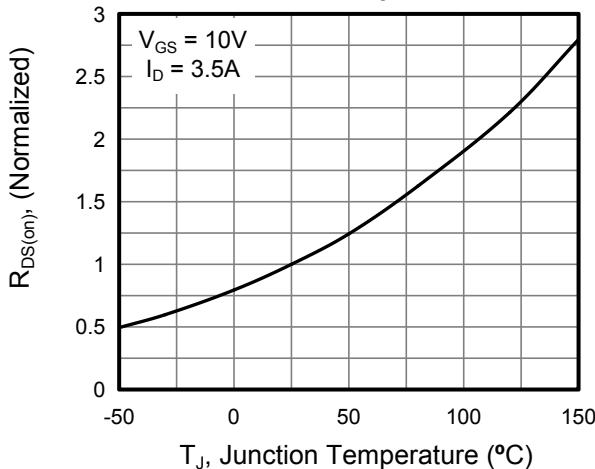


**Figure 6. Body Diode Forward Voltage**

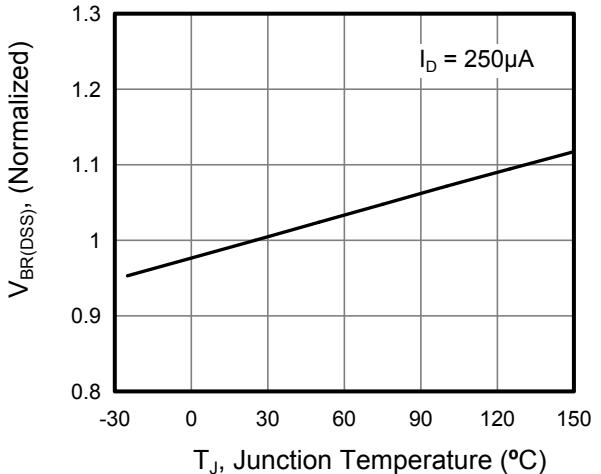


**Typical Characteristics**  $T_J = 25^\circ\text{C}$ , unless otherwise noted

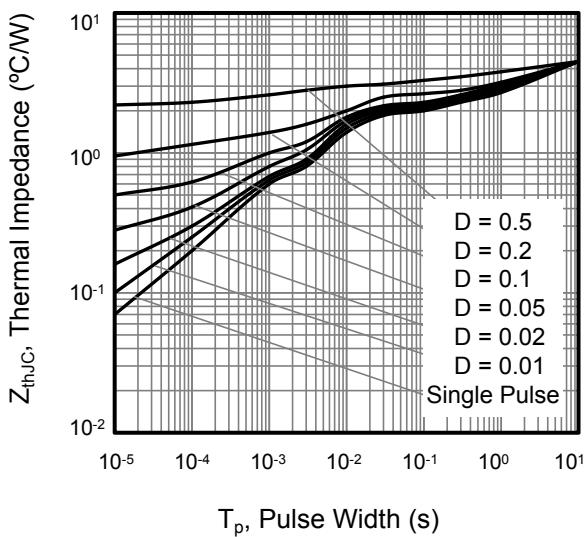
**Figure 7. On-Resistance vs. Junction Temperature**



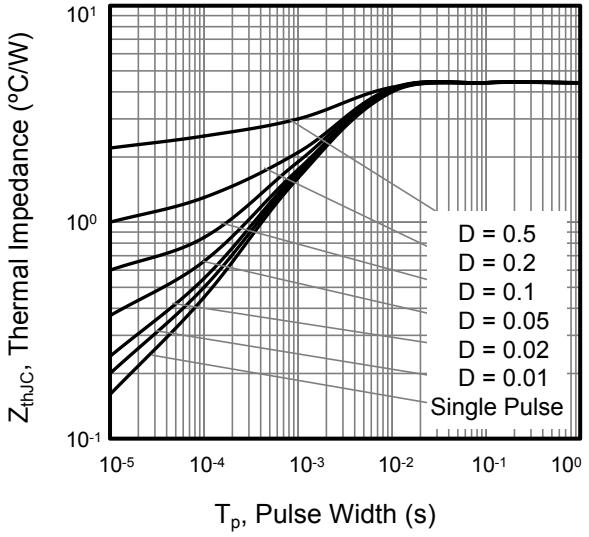
**Figure 8. Breakdown voltage vs. Junction Temperature**



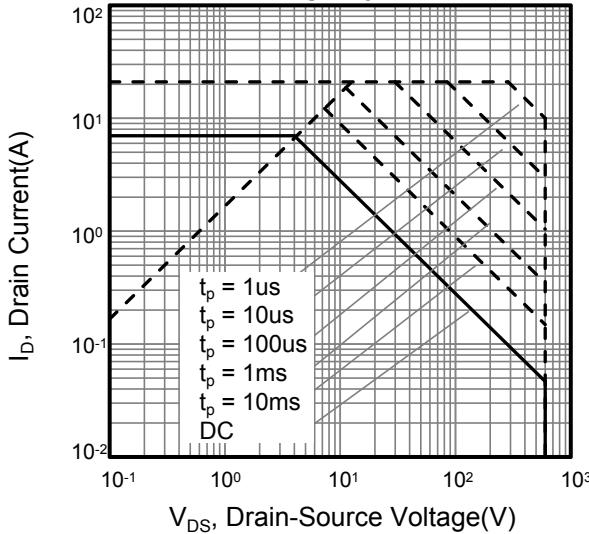
**Figure 9. Transient Thermal Impedance For TO-220F**



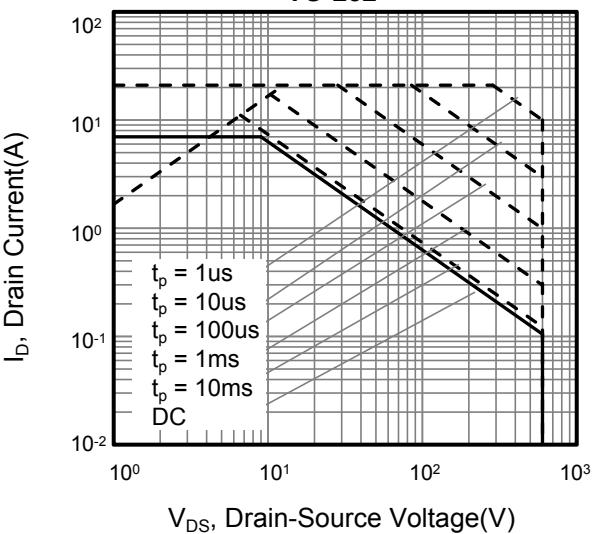
**Figure 10. Transient Thermal Impedance For TO-252**



**Figure 11. Safe Operation Area For TO-220F**



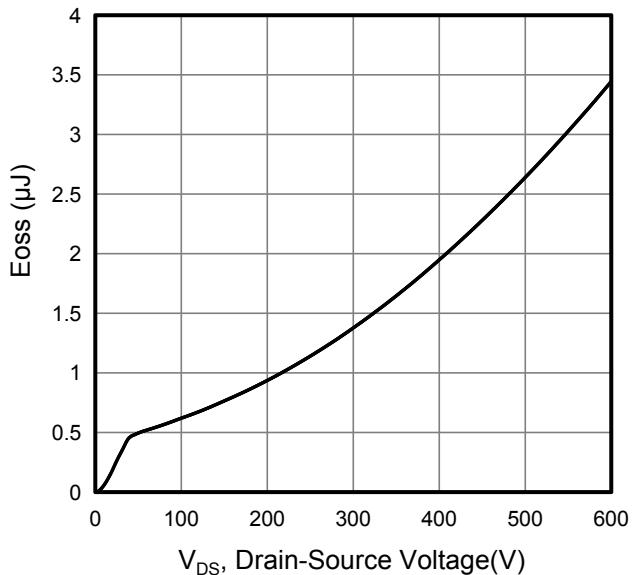
**Figure 12. Safe Operation Area For TO-252**

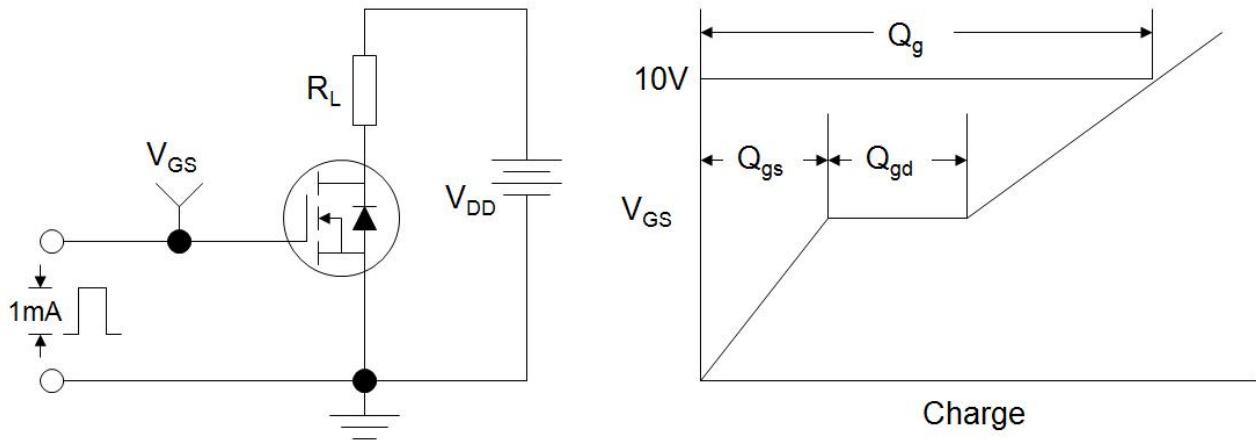
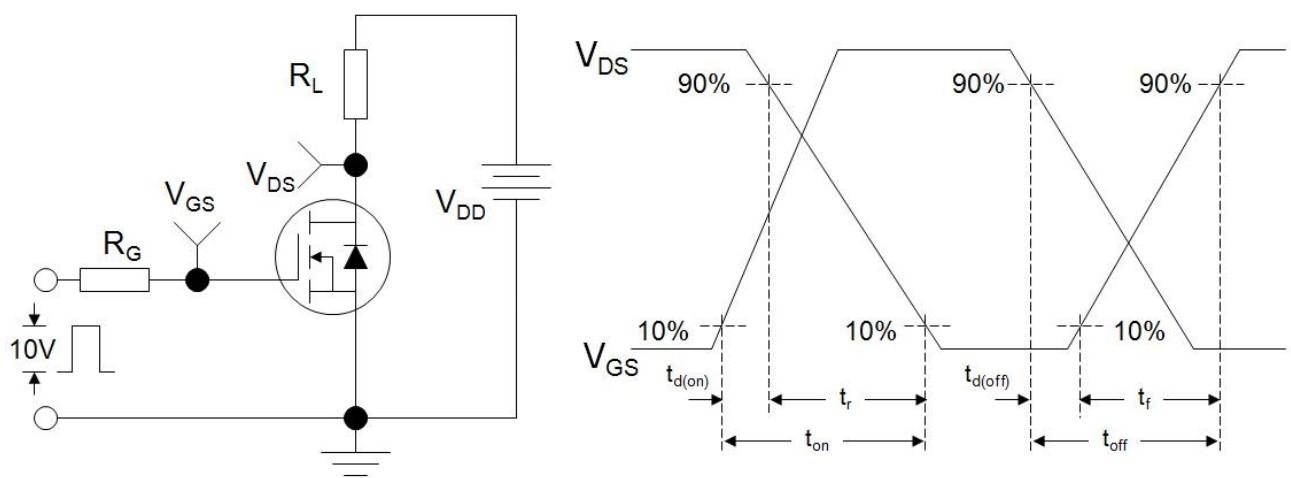
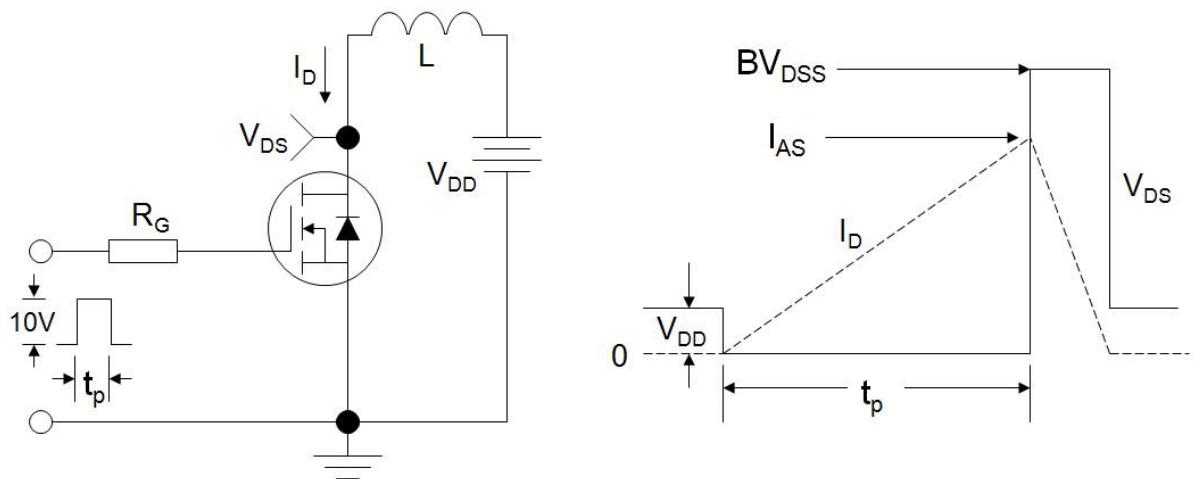




Typical Characteristics  $T_J = 25^\circ\text{C}$ , unless otherwise noted

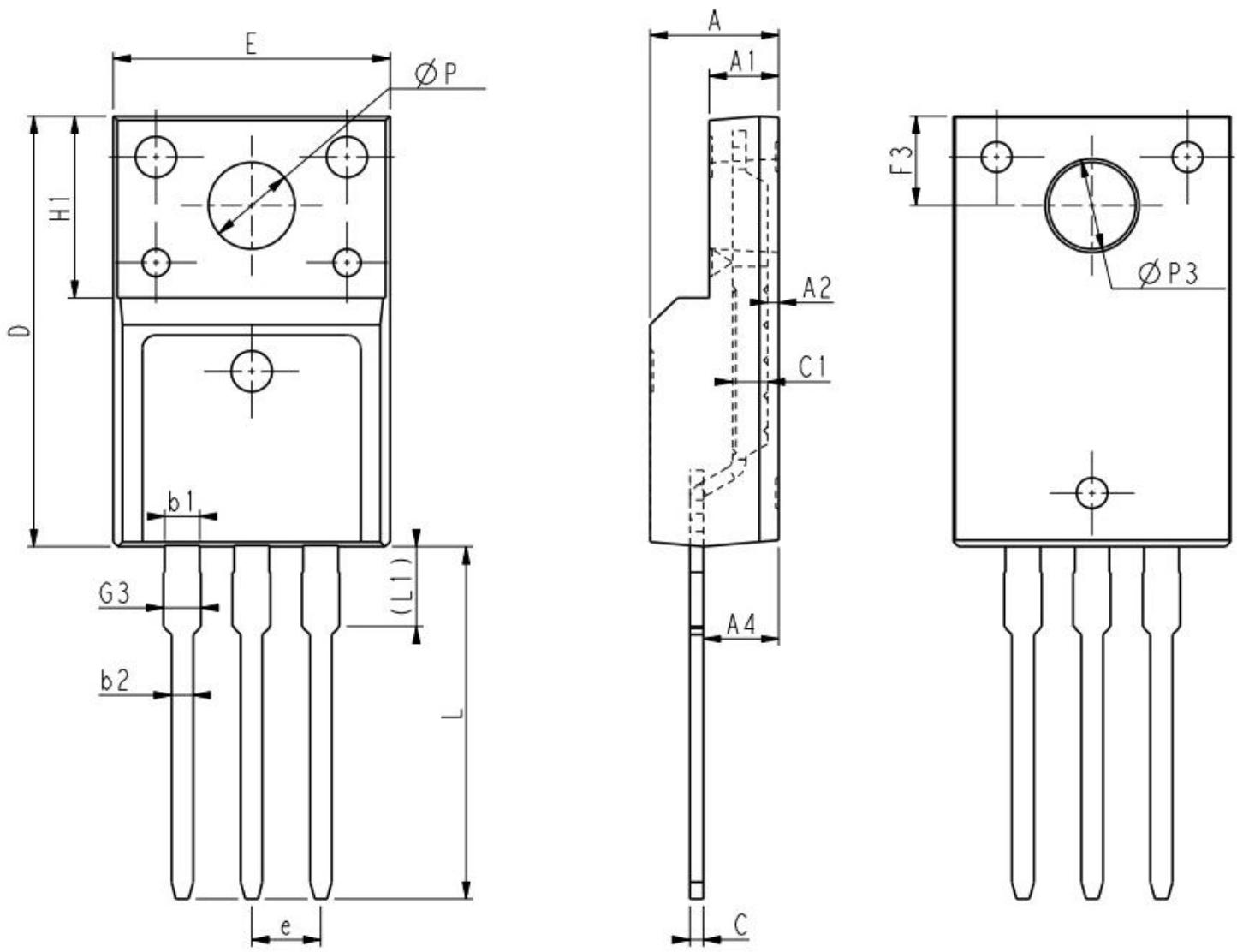
Figure 13. Typ. Coss Stored Energy



**Figure A: Gate Charge Test Circuit and Waveform****Figure B: Resistive Switching Test Circuit and Waveform****Figure C: Unclamped Inductive Switching Test Circuit and Waveform**



## TO-220F

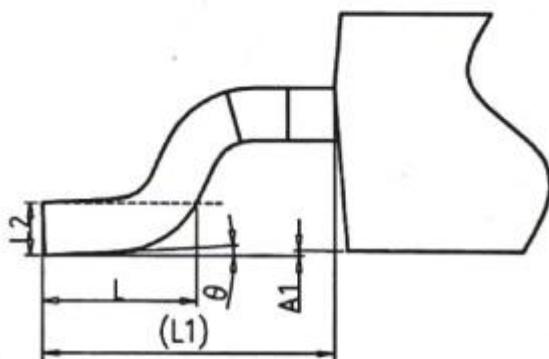
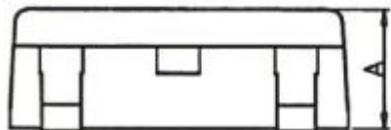
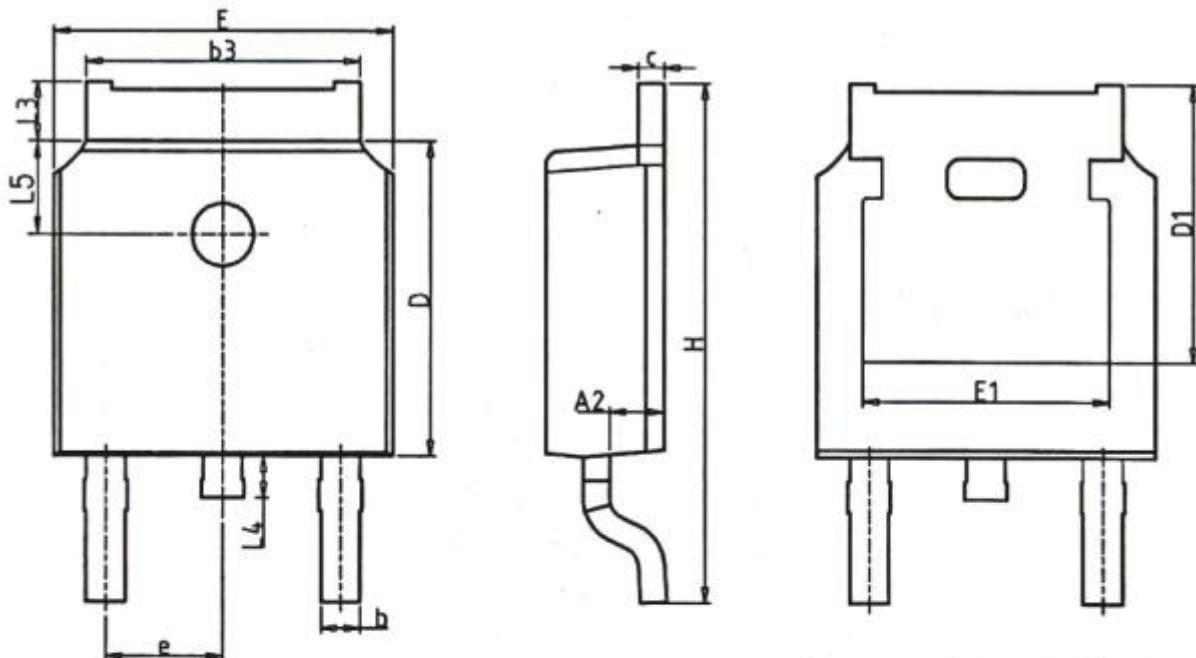


Unit:mm			
Symbol	Min.	Nom	Max.
E	9.96	10.16	10.36
A	4.50	4.70	4.90
A1	2.34	2.54	2.74
A2	0.30	0.45	0.60
A4	2.56	2.76	2.96
c	0.40	0.50	0.65
c1	1.20	1.30	1.35
D	15.57	15.87	16.17
H1	6.70REF		

Unit:mm			
Symbol	Min.	Nom	Max.
e	2.54BSC		
L	12.68	12.98	13.28
L1	2.93	3.03	3.13
ØP	3.03	3.18	3.38
ØP3	3.15	3.45	3.65
F3	3.15	3.30	3.45
G3	1.25	1.35	1.55
b1	1.18	1.28	1.43
b2	0.70	0.80	0.95



## TO-252



Unit:mm			
Symbol	Min.	Nom	Max.
A	2.20	2.30	2.40
A1	0.00	-	0.20
A2	0.97	1.07	1.17
b	0.68	0.78	0.90
b3	5.20	5.33	5.50
c	0.43	0.53	0.63
D	5.98	6.10	6.22
D1	5.30 REF		
E	6.40	6.60	6.80
E1	4.63	-	-

Unit:mm			
Symbol	Min.	Nom	Max.
e	2.286 BSC		
H	9.40	10.10	10.50
L	1.38	1.50	1.75
L1	2.90 REF		
L2	0.51 BSC		
L3	0.88	-	1.28
L4	-	-	1.00
L5	1.65	1.80	1.95
θ	0°	-	8°



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